Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/609,397	CHEN, CHUN-LIN
Examiner	Art Unit
Michael Koczo, Jr.	3746

	SEARCHED					
Class	Subclass	Date	Examiner			
417	223	11-21-05	MK			
	319	1				
	362	1	1			
-						

INT	INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner			
	<u> </u>					

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Consulted Freary EXST Search Strategy	11-21-25	MIC		
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